Application/Control No. Applicant(s)/Patent Under Reexamination 10/600,065 SHIEH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Dang T Nguyen 2824 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,791,880 B1 09-2004 Kurihara et al. 365/185.21 Α В US-2002/0145910 A1 10-2002 Kern et al. 365/185.21 С US-2003/0031059 A1 02-2003 Endo et al. 365/189.09 D US-E US-US-F US-G US-Н 1 US-US-J US-

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